

# NCX8193

## Audio jack detection and configuration with false detection prevention

Rev. 1 — 9 July 2014

Product data sheet

### 1. General description

The NCX8193 is an advanced audio jack accessory detector and controller. It supports 3- and 4-pole connectors and detects the insertion of plugs into jacks using a fault detection technique. An internal microphone bias line switch allows a codec or application processor to control the audio jack configuration. The device supports a broad variety of after-market headphones.

### 2. Features and benefits

- Fail-safe headset and headphone detection
- Low-power standby mode
- Click free switching
- Low THD and noise microphone pass through channel
- Send/End button detection
- Low ON resistance: 0.9  $\Omega$  (typical) at a supply voltage of 2.8 V
- ESD protection:
  - ◆ HBM JEDEC JDS-001 Class 3B exceeds 8 kV
- Operating ambient temperature  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$

### 3. Applications

- Headphones with integrated microphone and remote control buttons

### 4. Ordering information

Table 1. Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
NCX8193GU	$-40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$	XQFN10	plastic, extremely thin quad flat package; no leads; 10 terminals; body 1.8 x 1.4 x 0.5 mm	SOT1160-2

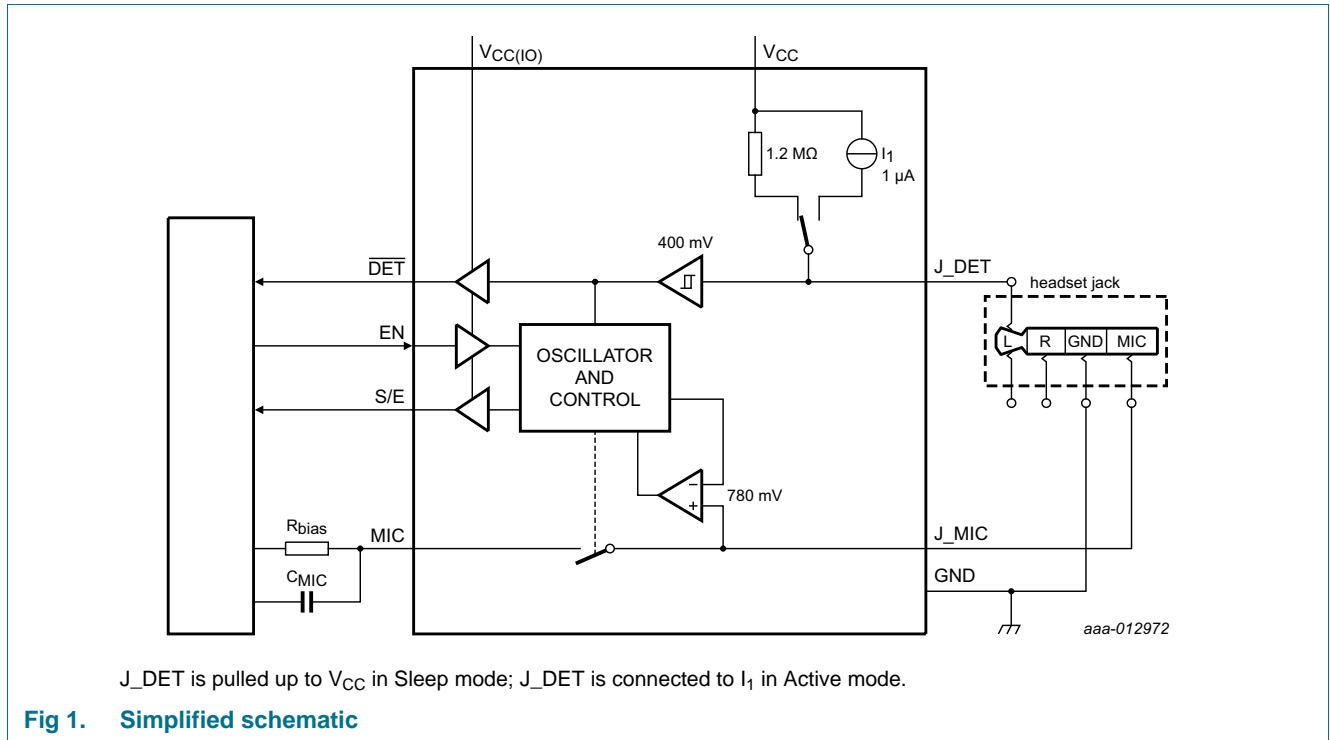
### 5. Marking

Table 2. Marking codes

Type number	Marking code
NCX8193GU	q8

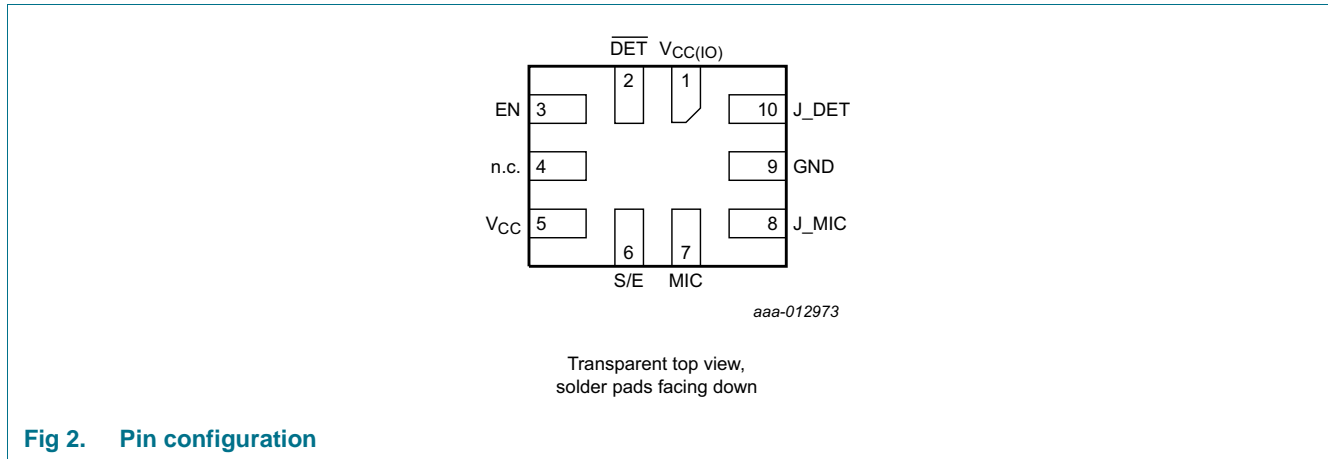


## 6. Functional diagram



## 7. Pinning information

### 7.1 Pinning



**Fig 2. Pin configuration**

### 7.2 Pin description

**Table 3. Pin description**

Symbol	Pin	Type	Description
$V_{CC(I/O)}$	1	Power	digital interface input/output supply voltage; headphone mode bias supply
$\overline{DET}$	2	O	plug detect; Plug inserted: $\overline{DET}$ = LOW; unplugged: $\overline{DET}$ = HIGH
EN	3	I	microphone bias path switch SWM control. closed: EN = HIGH; open: EN = LOW
n.c.	4	n.c.	not connected (preferably connected GND)
$V_{CC}$	5	Power	core supply (e.g. battery)
S/E	6	O	keypress-detect; key press: S/E = HIGH; NO key press: S/E = LOW
MIC	7	I/O	microphone bias connection audio codec side
J_MIC	8	I/O	microphone bias connection audio headset side
GND	9	ground	ground
J_DET	10	I/O	plug detection bias and logic level input

## 8. Functional description

The simplified schematic of the NCX8193 is shown in [Figure 1](#).

If no plug is inserted, J\_DET is pulled-up to V<sub>CC</sub> via a 1.2 MΩ resistor. Once J\_DET is pulled below 400 mV, the pull-up resistor is switched out and J\_DET is connected to a variable current source. The current source slowly increases its output current. If J\_DET remains lower than 300 mV,  $\overline{\text{DET}}$  is set LOW to indicate that a plug has been inserted.

In case  $\overline{\text{DET}}$  is set LOW, when EN is HIGH, J\_DET is connected to the current source and the integrated button press detection circuit on J\_MIC is active. The button press detection uses a trigger level of 780 mV. It enables a 1.8 V bias voltage in combination with an R<sub>bias</sub>, matching the series resistance of the microphone, to detect button presses. Not only call-end button press but also forward and reverse button press event levels can be passed from J\_MIC to MIC. The codec or processor decodes according to the individual button pressed. Refer to [Figure 3](#) and [Figure 4](#) for details.

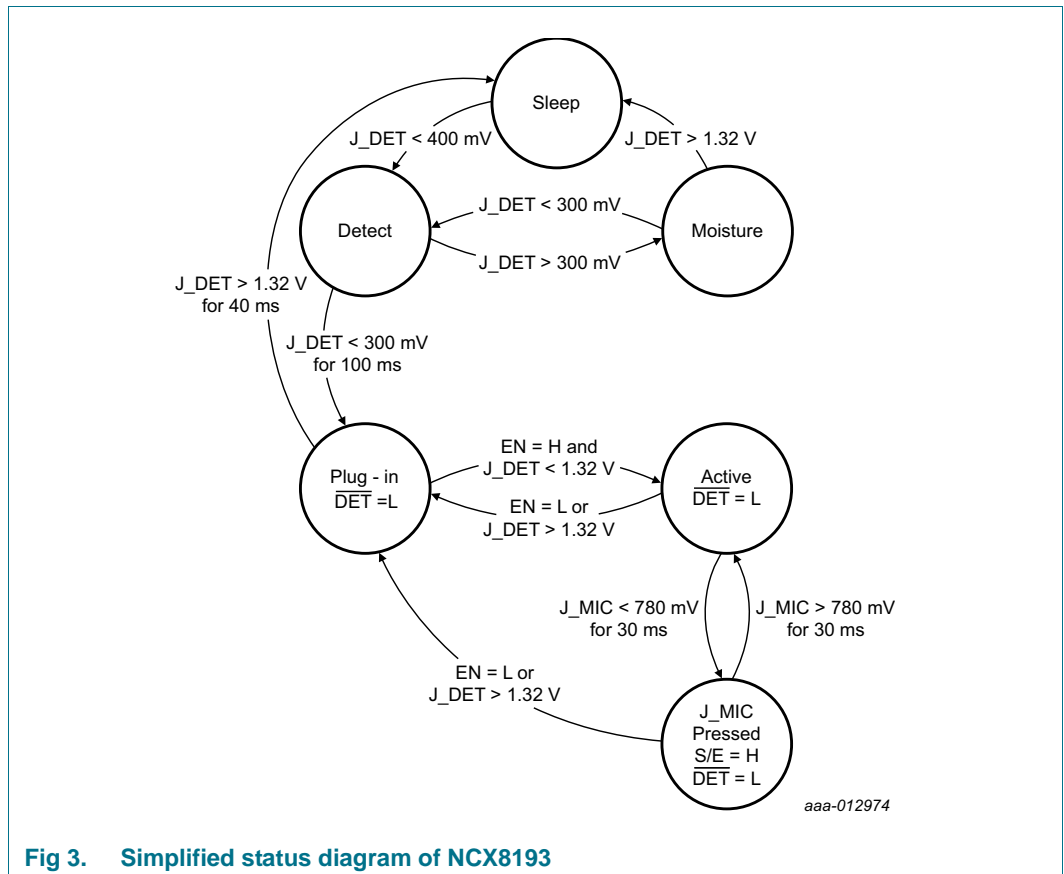


Fig 3. Simplified status diagram of NCX8193

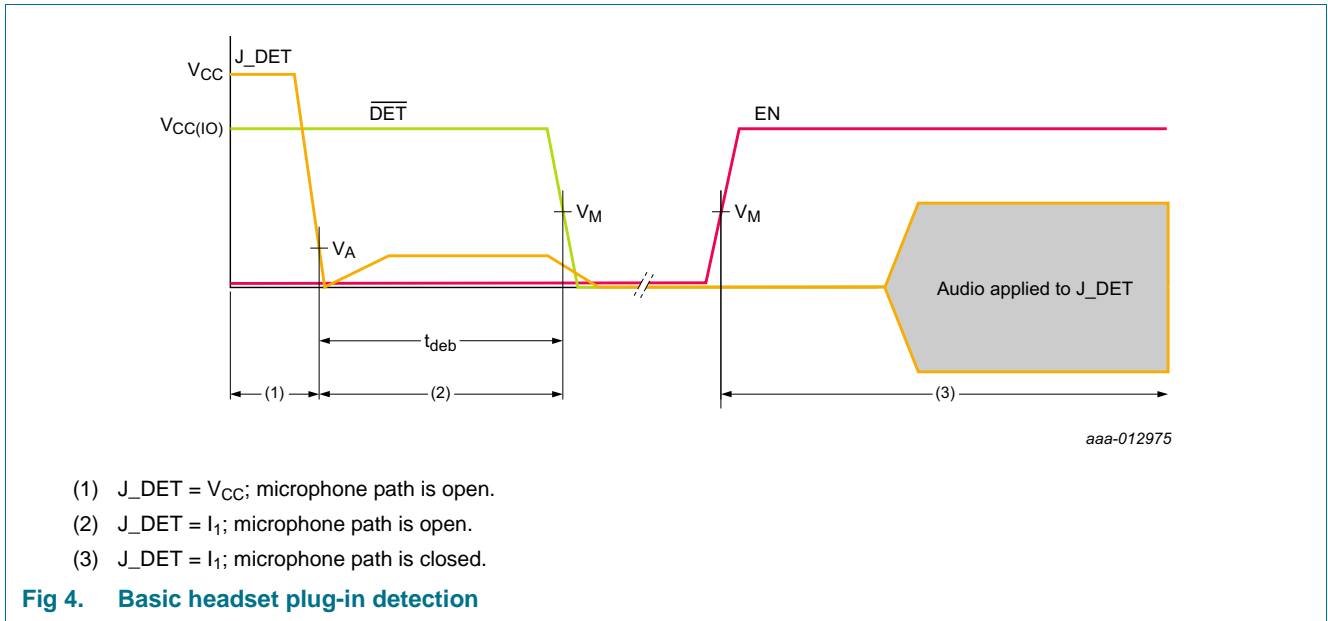


Table 4. Simplified status diagram signal and functional conditions<sup>[1]</sup>

		States					
		Sleep	Detect	Moisture	Plug-in	Active	J_MIC pressed
I/O	J_DET	H	L	0.3 V	audio signal	audio signal	audio signal
Input	EN	X	X	X	L	H	H
I/O	J_MIC	L	L	L	L	> 780 mV	< 780 mV
I/O	MIC	Z	Z	Z	Z	J_MIC	J_MIC
Output	$\overline{\text{DET}}$	H <sup>[2]</sup>	H	H	L	L	L
Output	S/E	L	L	L	L	L	H

[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

[2] In case an unplug event is detected,  $\overline{\text{DET}}$  remains LOW for 40 ms before returning to HIGH.

## 9. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+6.0	V
V <sub>CC(10)</sub>	input/output supply voltage		-0.5	+6.0	V
V <sub>I</sub>	input voltage	J_MIC; MIC	-0.5	V <sub>CC</sub>	V
		EN	-0.5	V <sub>CC(10)</sub> + 0.1	V
		J_DET	-1.5	V <sub>CC</sub>	V
V <sub>O</sub>	output voltage	$\overline{\text{DET}}$ ; S/E	-0.5	V <sub>CC(10)</sub> + 0.3	V
ΔV	voltage difference	V <sub>CC</sub> to J_DET	-	6.0	V
I <sub>sw</sub>	switch current	continuous current from MIC to J_MIC	-	50	mA

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**Table 5. Limiting values ...continued**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
$T_{j(max)}$	maximum junction temperature		-40	+125	°C
$T_{stg}$	storage temperature		-65	+150	°C
$P_{tot}$	total power dissipation		-	250	mW

## 10. Recommended operating conditions

**Table 6. Recommended operating conditions**

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		2.4	5.25	V
$V_{CC(IO)}$	input/output supply voltage	$V_{CC(IO)} \leq V_{CC}$	1.6	$V_{CC}$	V
$V_I$	input voltage	MIC; J_MIC	0	$V_{CC}$	V
$\Delta V$	voltage difference	$V_{CC}$ to J_DET	-	5.5	V
$T_{amb}$	ambient temperature		-40	+85	°C

## 11. Thermal characteristics

**Table 7. Thermal characteristics**

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient		<a href="#">[1]</a> 148	K/W

- [1]  $R_{th(j-a)}$  is dependent upon board layout. To minimize  $R_{th(j-a)}$ , ensure that all pins have a solid connection to larger copper layer areas. In multi-layer PCBs, the second layer should be used to create a large heat spreader area below the device. Avoid using solder-stop varnish under the device.

## 12. Static characteristics

**Table 8. Static characteristics**

At recommended operating conditions, unless otherwise specified typical values are measured with  $V_{CC} = 3.6$  V and  $V_{CC(IO)} = 1.8$  V; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	$T_{amb} = 25$ °C			$T_{amb} = -40$ °C to $+85$ °C		Unit
			Min	Typ	Max	Min	Max	
<b>Digital control</b>								
$V_{IH}$	HIGH-level input voltage	EN	-	-	-	$0.7V_{CC(IO)}$	-	V
$V_{IL}$	LOW-level input voltage	EN	-	-	-	-	$0.3V_{CC(IO)}$	V
$V_{OH}$	HIGH-level output voltage	$\overline{\overline{DET}}$ ; S/E; $I_O = 0.5$ mA	-	-	-	$0.8V_{CC(IO)}$	-	V
$V_{OL}$	LOW-level output voltage	$\overline{\overline{DET}}$ ; S/E; $I_O = 0.5$ mA	-	-	-	-	$0.2V_{CC(IO)}$	V
$C_I$	input capacitance	J_DET	-	5	-	-	-	pF
		EN	-	1	-	-	-	pF

**Audio jack detection and configuration with false detection prevention**

**Table 8. Static characteristics ...continued**

At recommended operating conditions, unless otherwise specified typical values are measured with  $V_{CC} = 3.6\text{ V}$  and  $V_{CC(IO)} = 1.8\text{ V}$ ; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	$T_{amb} = 25\text{ °C}$			$T_{amb} = -40\text{ °C to }+85\text{ °C}$		Unit
			Min	Typ	Max	Min	Max	
<b>Microphone bias switch</b>								
$I_{S(OFF)}$	OFF-state leakage current	MIC; $V_{I(MIC)} = 850\text{ mV}$ ; see <a href="#">Figure 5</a>	-	-	-	-	0.1	$\mu\text{A}$
$R_{ON}$	ON resistance	MIC; $I_{O(J\_MIC)} = 30\text{ mA}$ ; $V_{I(MIC)} = 850\text{ mV}$ ; see <a href="#">Figure 6</a> and <a href="#">Figure 7</a>						
		$V_{CC} = 2.8\text{ V}$ ; see <a href="#">Figure 8</a>	-	0.9	-	-	1.5	$\Omega$
		$V_{CC} = 3.0\text{ V}$ ; see <a href="#">Figure 9</a>	-	0.9	-	-	1.5	$\Omega$
		$V_{CC} = 3.3\text{ V}$ ; see <a href="#">Figure 10</a>	-	0.9	-	-	1.5	$\Omega$
$R_{ON(flat)}$	ON resistance (flatness)	$I_{O(J\_MIC)} = 30\text{ mA}$ ; $0.8\text{ V} < V_{I(MIC)} < 1.2\text{ V}$						
		$V_{CC} = 2.8\text{ V}$ ; see <a href="#">Figure 8</a>	-	-	-	-	0.6	$\Omega$
		$V_{CC} = 3.0\text{ V}$ ; see <a href="#">Figure 9</a>	-	-	-	-	0.6	$\Omega$
		$V_{CC} = 3.3\text{ V}$ ; see <a href="#">Figure 10</a>	-	-	-	-	0.6	$\Omega$
$C_{S(OFF)}$	OFF-state capacitance	J_MIC; MIC	-	20	-	-	-	pF
		J_MIC; MIC	-	60	-	-	-	pF
<b>Audio/analog performance</b>								
THD	total harmonic distortion	$R_S = R_L = 600\ \Omega$ ; $V_{AC} = 0.5\text{ V (p-p)}$ ; $V_{DC} = 1.7\text{ V}$ ; $f_i = 20\text{ Hz to }20\text{ kHz}$ ; $V_{CC} = 3.8\text{ V}$ ; $V_{CC(IO)} = 1.8\text{ V}$ ; see <a href="#">Figure 12</a>	-	0.01	-	-	-	%
$\alpha_{iso}$	isolation (OFF-state)	$R_S = R_L = 32\ \Omega$ ; $V_{AC} = 0.1\text{ V (p-p)}$ ; $V_{DC} = 2.2\text{ V}$ ; $f_i = 20\text{ kHz}$ ; $V_{CC} = 3.8\text{ V}$ ; $V_{CC(IO)} = 1.8\text{ V}$ ; see <a href="#">Figure 13</a>	-	-100	-	-	-	dB
PSRR	power supply rejection ratio	$R_S = R_L = 600\ \Omega$ ; $V_{CC} = 3.8\text{ V}$ ; $V_{CC(IO)} = 1.8\text{ V}$ ; $V_{DC} = 1.7\text{ V}$ ; $V_{AC} = 0.3\text{ V (p-p)}$ ; $f_i = 217\text{ Hz}$ ; see <a href="#">Figure 14</a>	-	-110	-	-	-	dB

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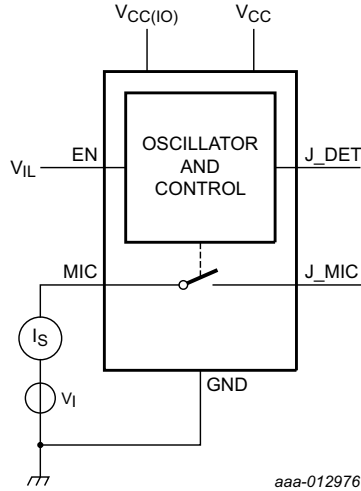
**Table 8. Static characteristics ...continued**

At recommended operating conditions, unless otherwise specified typical values are measured with  $V_{CC} = 3.6\text{ V}$  and  $V_{CC(IO)} = 1.8\text{ V}$ ; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	$T_{amb} = 25\text{ °C}$			$T_{amb} = -40\text{ °C to }+85\text{ °C}$		Unit
			Min	Typ	Max	Min	Max	
<b>Headset detection</b>								
$V_{T-}$	negative-going threshold voltage	J_DET	-	-	-	-	400	mV
$V_{ref}$	reference voltage	J_DET; plug detect	-	300	-	270	330	mV
		J_DET; plug removed; $1.6\text{ V} < V_{CC(IO)} < V_{CC}$	-	1.32	-	1.2	1.44	V
$f_{max}$	maximum frequency	J_DET	-	-	-	20000	-	Hz
$R_{pu}$	pull-up resistance	J_DET	-	1.2	-	0.9	1.6	$M\Omega$
$I_{source}$	source current	J_DET	-	1.0	-	-	-	$\mu\text{A}$
<b>Button press; S/E detect</b>								
$V_{ref}$	reference voltage	J_MIC	-	780	-	718	842	mV
<b>Current consumption</b>								
$I_{CC}$	supply current	power down; $V_{CC(IO)} = 0\text{ V}$ ; $V_{CC} = 3.6\text{ V}$ ; J_DET = open	-	0.1	-	-	1	$\mu\text{A}$
$I_{CC(tot)}$	total supply current	$I_{CC(IO)} + I_{CC}$ ; $1.6\text{ V} < V_{CC(IO)} < 2.0\text{ V}$ ; $V_{CC} = 3.6\text{ V}$ ;						
		Sleep mode; J_DET = open	-	0.1	-	-	1	$\mu\text{A}$
		Plug-in mode	-	15	-	-	25	$\mu\text{A}$
		Active mode	-	15	-	-	25	$\mu\text{A}$

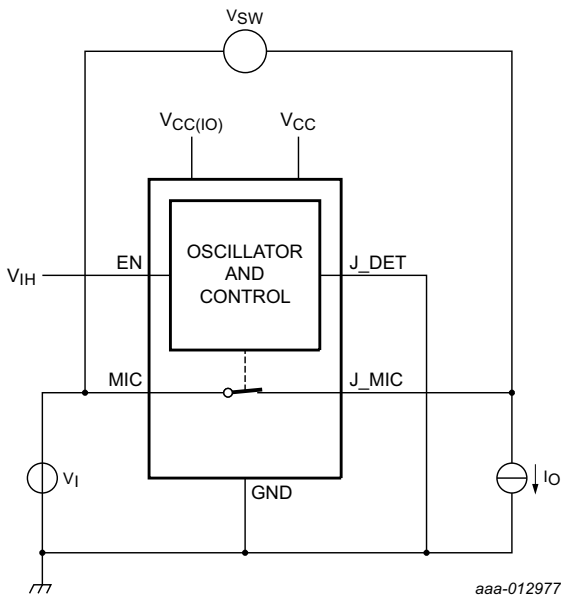


12.1 Test circuits and graphs



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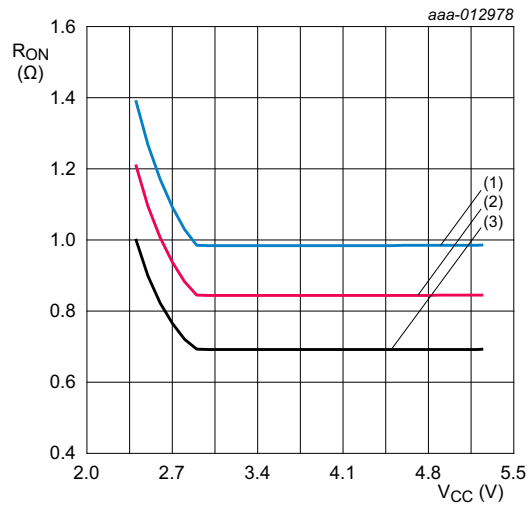
Fig 5. Test circuit for measuring OFF-state leakage current



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$R_{ON} = V_{SW} / I_o$

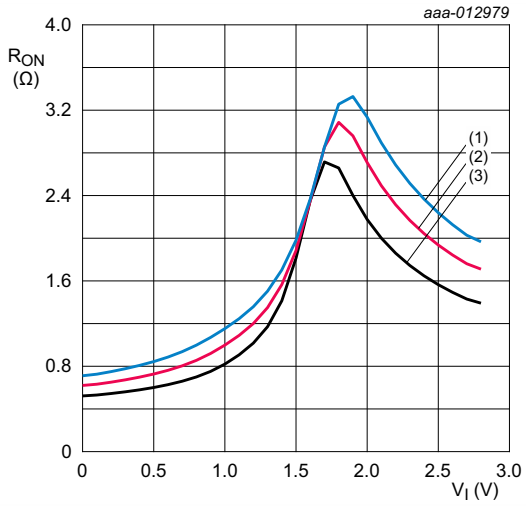
Fig 6. Test circuit for measuring ON resistance



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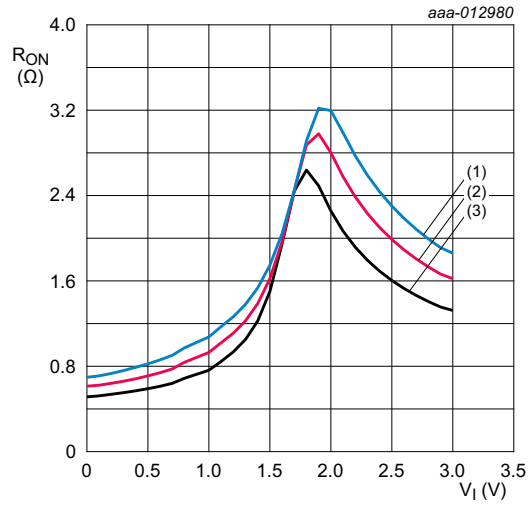
- (1)  $T_{amb} = 85\text{ }^{\circ}\text{C}$
- (2)  $T_{amb} = 25\text{ }^{\circ}\text{C}$
- (3)  $T_{amb} = -40\text{ }^{\circ}\text{C}$

Fig 7. ON resistance versus VCC



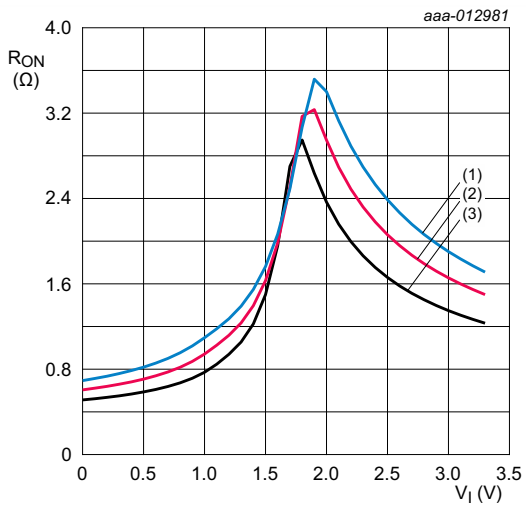
- (1)  $T_{amb} = 85$  °C
- (2)  $T_{amb} = 25$  °C
- (3)  $T_{amb} = -40$  °C

Fig 8. ON resistance as a function of  $V_{I(MIC)}$ ;  $V_{CC} = 2.8$  V



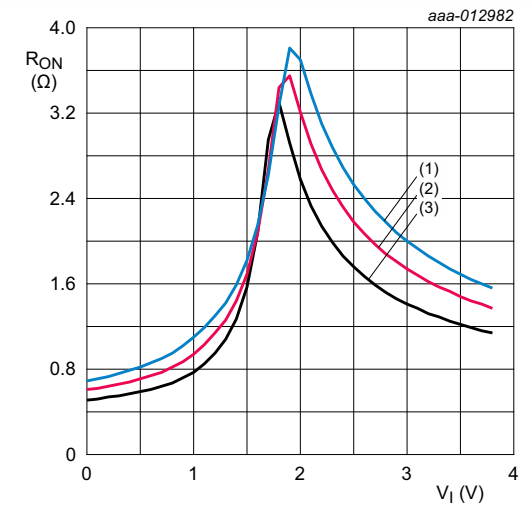
- (1)  $T_{amb} = 85$  °C
- (2)  $T_{amb} = 25$  °C
- (3)  $T_{amb} = -40$  °C

Fig 9. ON resistance as a function of  $V_{I(MIC)}$ ;  $V_{CC} = 3.0$  V



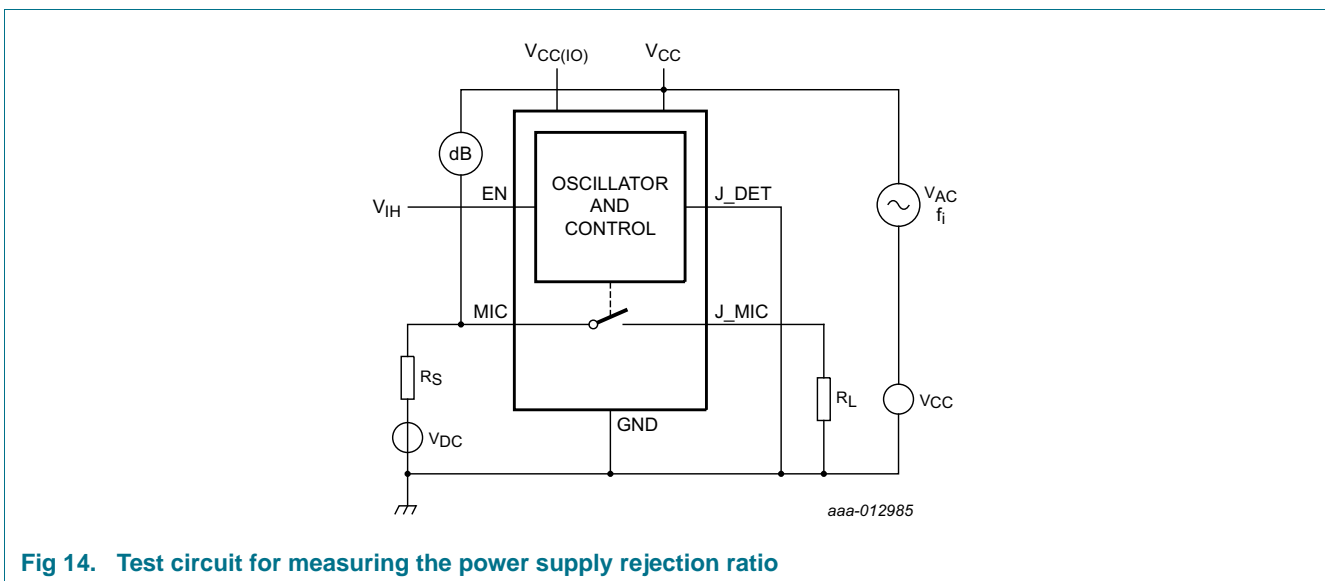
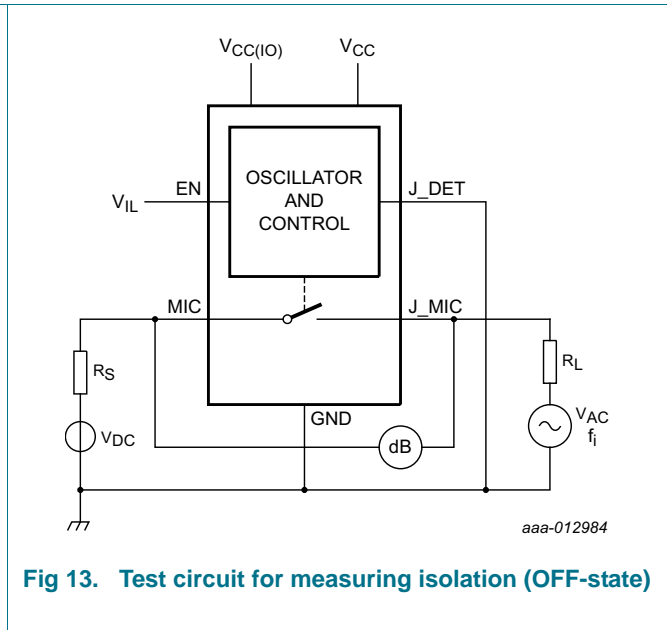
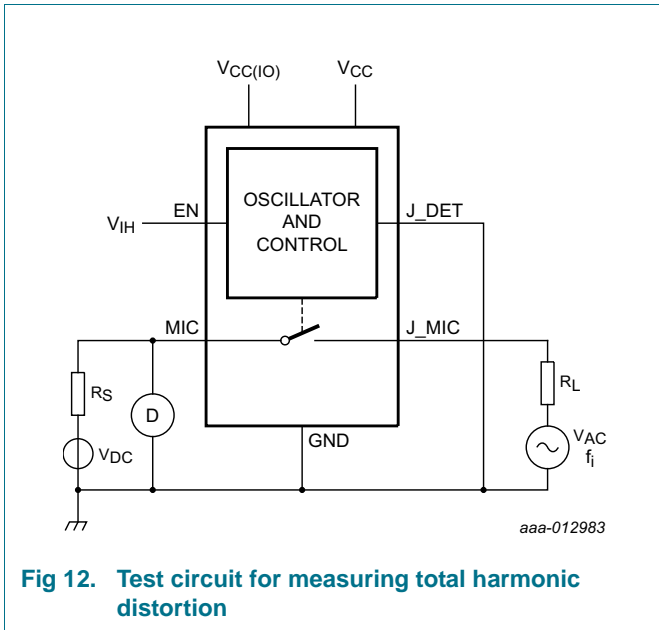
- (1)  $T_{amb} = 85$  °C
- (2)  $T_{amb} = 25$  °C
- (3)  $T_{amb} = -40$  °C

Fig 10. ON resistance as a function of  $V_{I(MIC)}$ ;  $V_{CC} = 3.3$  V



- (1)  $T_{amb} = 85$  °C
- (2)  $T_{amb} = 25$  °C
- (3)  $T_{amb} = -40$  °C

Fig 11. ON resistance as a function of  $V_{I(MIC)}$ ;  $V_{CC} = 3.8$  V



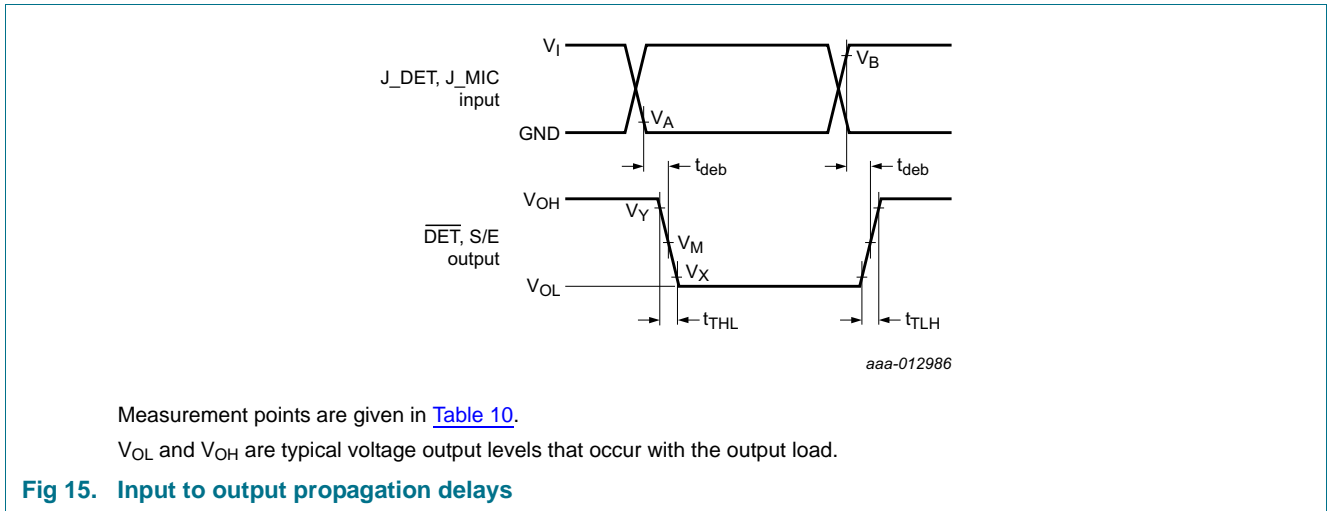
### 13. Dynamic characteristics

**Table 9. Dynamic characteristics**

At recommended operating conditions; unless otherwise specified typical values are measured with  $V_{CC} = 3.6\text{ V}$  and  $V_{CC(IO)} = 1.8\text{ V}$ ; voltages are referenced to GND (ground = 0 V); see [Figure 18](#).

Symbol	Parameter	Conditions	$T_{amb} = 25\text{ °C}$			$T_{amb} = -40\text{ °C to }+85\text{ °C}$		Unit	
			Min	Typ	Max	Min	Max		
$t_{TLH}$	LOW to HIGH output transition time	$\overline{DET}$ ; S/E; $C_L = 5\text{ pF}$ ; see <a href="#">Figure 15</a> and <a href="#">Figure 18</a>	-	5	-	-	-	ns	
$t_{THL}$	HIGH to LOW output transition time	$\overline{DET}$ ; S/E; $C_L = 5\text{ pF}$ ; see <a href="#">Figure 15</a> and <a href="#">Figure 18</a>	-	2	-	-	-	ns	
$t_{deb}$	debounce time	see <a href="#">Figure 15</a> and <a href="#">Figure 18</a>							
		Detect to Plug-in	-	80	-	-	100	ms	
		Plug-in to Sleep	-	40	-	-	-	ms	
$t_{en}$	enable time	EN to J_MIC; $V_{I(MIC)} = V_{CC}$ ; see <a href="#">Figure 16</a> and <a href="#">Figure 19</a>	-	15	-	-	-	$\mu\text{s}$	
		$t_{dis}$	disable time	$V_{I(MIC)} = V_{CC}$ ;					
				EN to J_MIC; see <a href="#">Figure 16</a> and <a href="#">Figure 19</a>	-	15	-	-	-
		J_DET to J_MIC; see <a href="#">Figure 17</a>	-	15	-	-	-	$\mu\text{s}$	

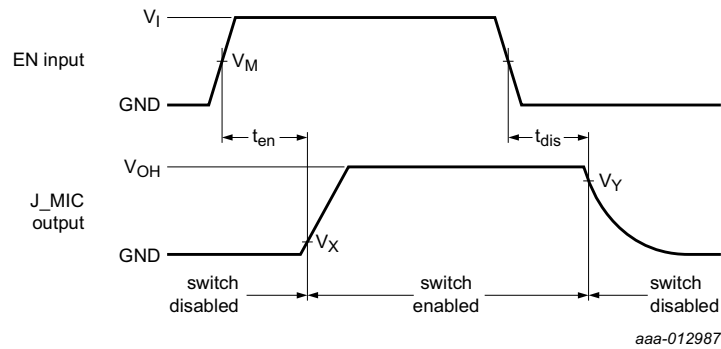
#### 13.1 Waveform and test circuits



**Table 10. Measurement points**

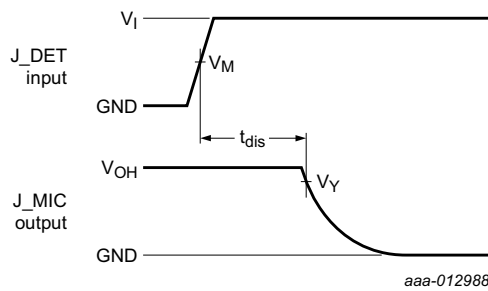
Supply voltage		Input J_DET		Input J_MIC		Output DET, S/E		
$V_{CC}$	$V_{CC(IO)}$	$V_A$	$V_B$	$V_A$	$V_B$	$V_M$	$V_X$	$V_Y$
3.6 V	1.8 V	0.05 V	1.44 V	0.7 V	0.85 V	$0.5V_{CC(IO)}$	$0.2V_{CC(IO)}$	$0.8V_{CC(IO)}$

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Measurement points are given in [Table 11](#).  
 Logic level:  $V_{OH}$  is the typical output voltage that occurs with the output load.

**Fig 16. Enable and disable times (EN to J\_MIC)**



Measurement points are given in [Table 11](#).  
 Logic level:  $V_{OH}$  is the typical output voltage that occurs with the output load.

**Fig 17. Enable and disable times (J\_DET to J\_MIC)**

**Table 11. Measurement points**

Supply Voltage		Input J_DET	Input EN	Output J_MIC	
$V_{CC}$	$V_{CC(10)}$	$V_M$	$V_M$	$V_X$	$V_Y$
3.6 V	1.8 V	1.44 V	$0.5V_{CC(10)}$	$0.1V_{CC}$	$0.9V_{CC}$

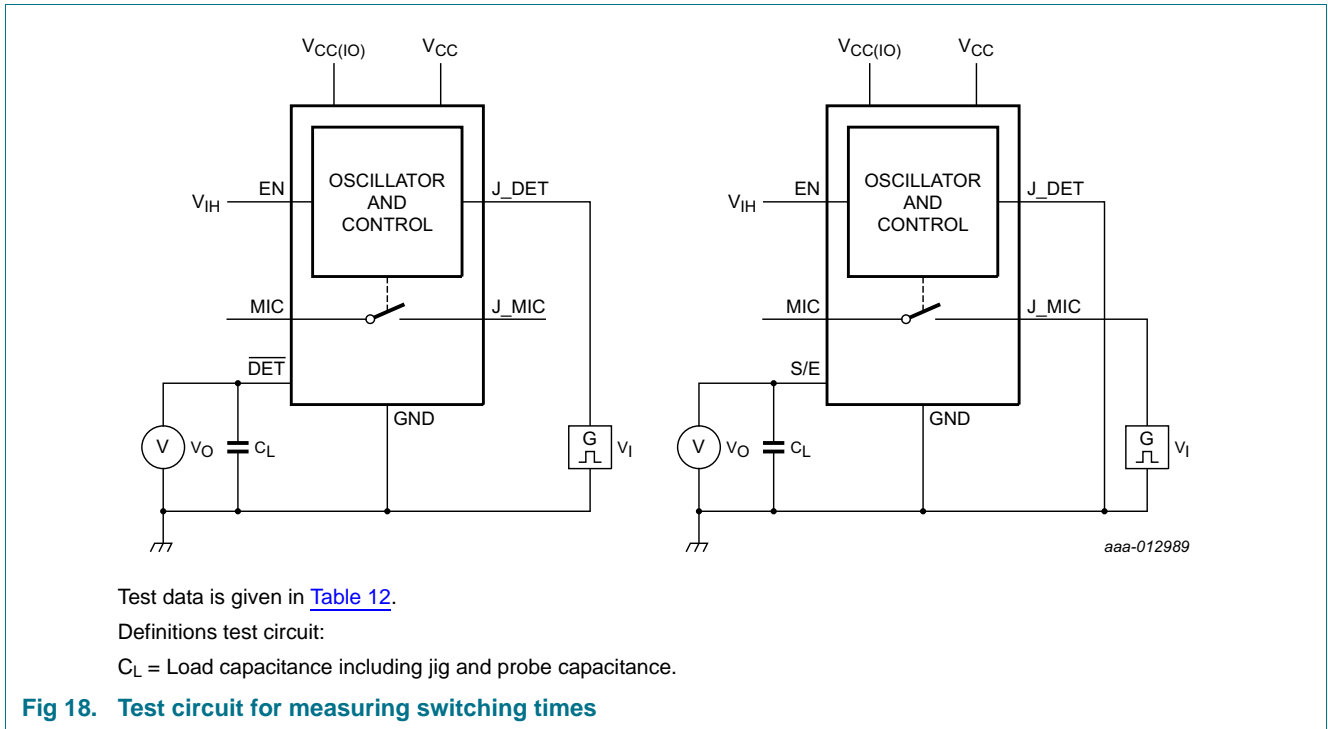


Table 12. Test data

Supply voltage		Input		Load
$V_{CC}$	$V_{CC(10)}$	$V_I$	$t_r, t_f$	$C_L$
2.4 V to 5.25 V	1.6 V to $V_{CC}$	$V_{CC}$	$\leq 2.5$ ns	5 pF

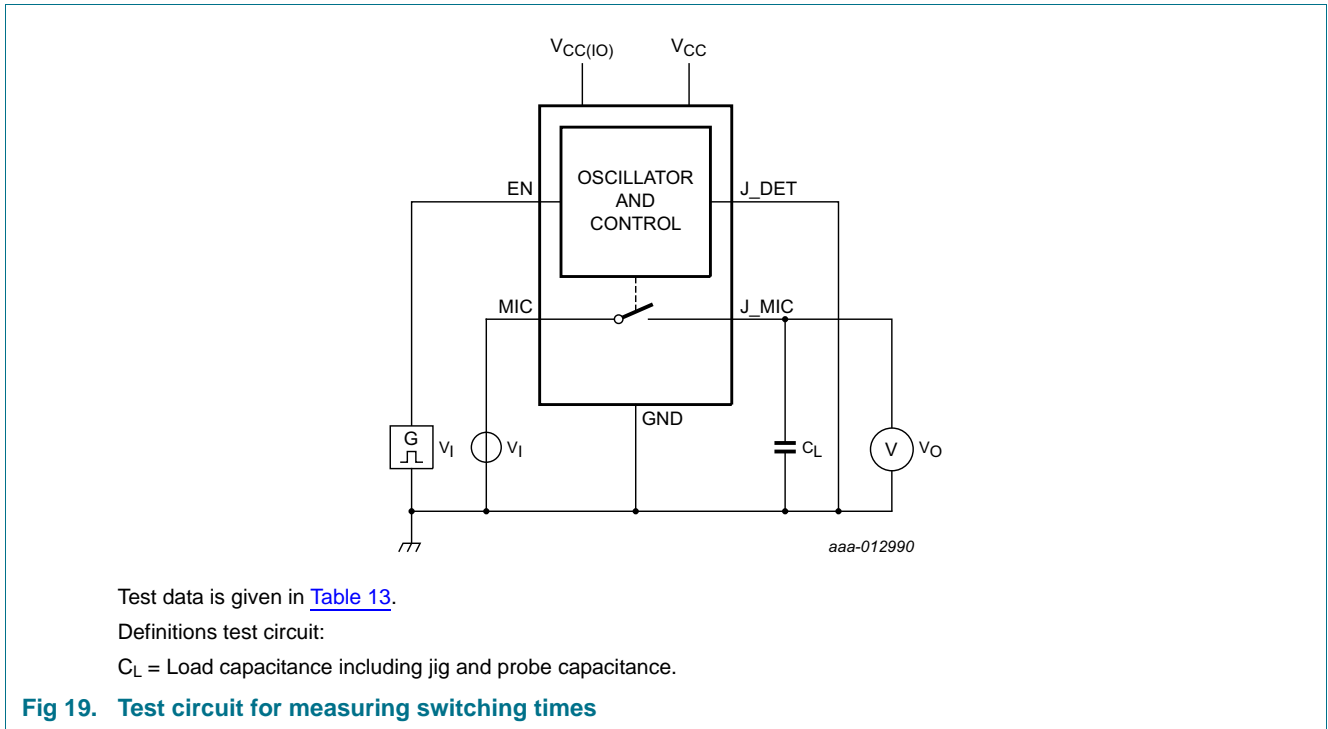


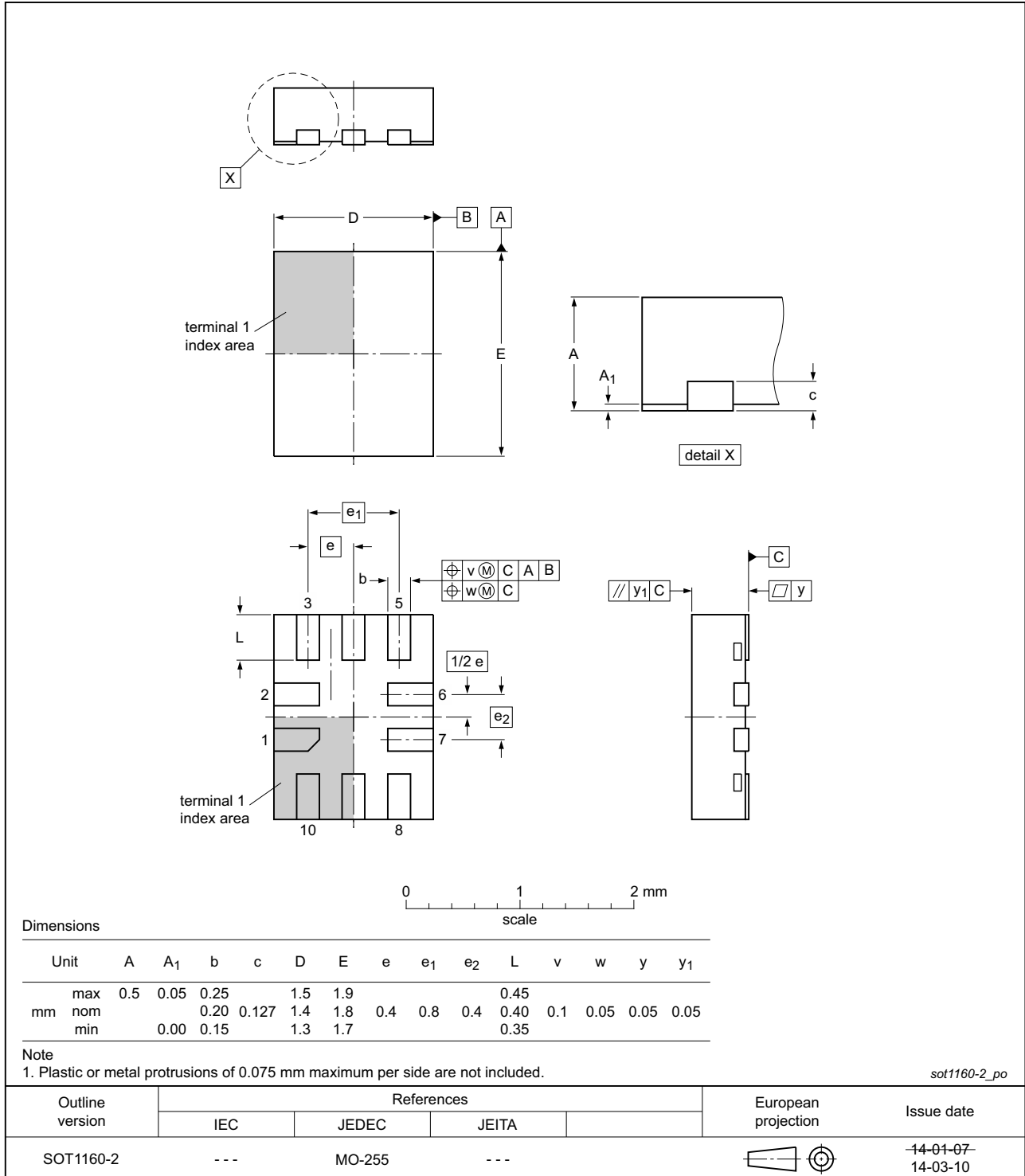
Table 13. Test data

Supply voltage		Input			Load
$V_{CC}$	$V_{CC(10)}$	$V_{I(EN)}$	$V_{I(J\_MIC)}$	$t_r, t_f$	$C_L$
2.4 V to 5.25 V	1.6 V to $V_{CC}$	$V_{CC(10)}$	$V_{CC}$	$\leq 2.5$ ns	5 pF

### 14. Package outline

**XQFN10: plastic, extremely thin quad flat package; no leads; 10 terminals; body 1.8 x 1.4 x 0.5 mm**

**SOT1160-2**



**Fig 20. Package outline XQFN10 (SOT1160-2) package**



## 15. Abbreviations

Table 14. Abbreviations

Acronym	Description
CDM	Charged Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MOSFET	Metal-Oxide Semiconductor Field Effect Transistor
THD	Total Harmonic Distortion

## 16. Revision history

Table 15. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
NCX8193 v.1	20140709	Product data sheet	-	-

## 17. Legal information

### 17.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

### 17.2 Definitions

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## Audio jack detection and configuration with false detection prevention

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Date of release: 9 July 2014  
 Document identifier: NCX8193